

P-Channel JFETs

Product Summary

Part Number	V _{GS(off)} (V)	V _{(BR)GSS} Min (V)	g _{fS} Min (mS)	I _{DSS} Min (mA)
2N5460	0.75 to 6	40	1	-1
2N5461	1 to 7.5	40	1.5	-2
2N5462	1.8 to 9	40	2	-4

Features

- High Input Impedance
- Very Low Noise
- High Gain: A_V = 80 @ 20 μA

Benefits

- Low Signal Loss/System Error
- High System Sensitivity
- High-Quality Low-Level Signal Amplification

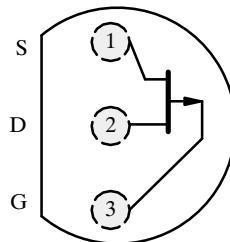
Applications

- Low-Current, Low-Voltage Amplifiers
- High-Side Switching
- Ultrahigh Input Impedance Pre-Amplifiers

Description

The 2N5460/5461/5462 are p-channel JFETs designed to provide all-around performance in a wide range of amplifier and analog switch applications.

The TO-226AA (TO-92) plastic package provides a low cost option, and the series is also available in tape-and-reel for automated assembly, (see Packaging Information).

TO-226AA
(TO-92)

Top View

Absolute Maximum Ratings

Gate-Drain Voltage	40 V
Gate-Source Voltage	40 V
Gate Current	-10 mA
Storage Temperature	-65 to 150°C
Operating Junction Temperature	-55 to 150°C

Lead Temperature (1/16" from case for 10 sec.)	300°C
Power Dissipation ^a	350 mW

Notes

a. Derate 2.8 mW/°C above 25°C

2N5460/5461/5462

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Specifications^a

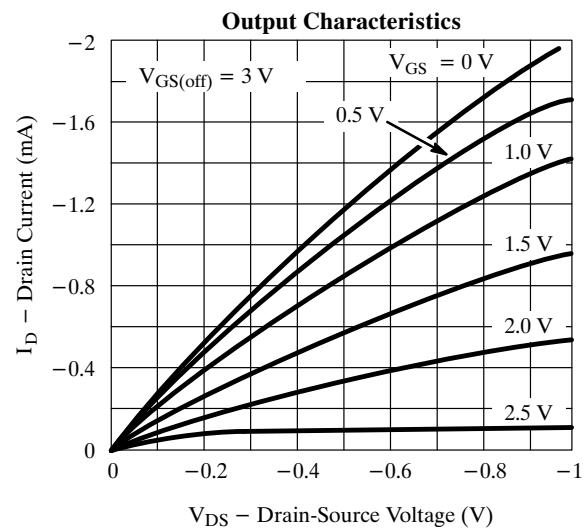
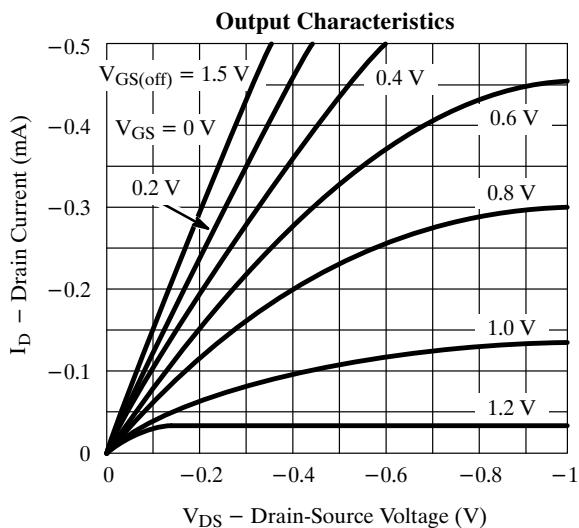
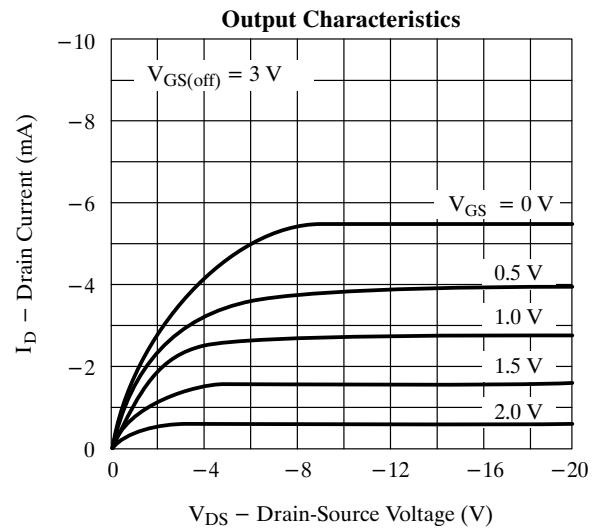
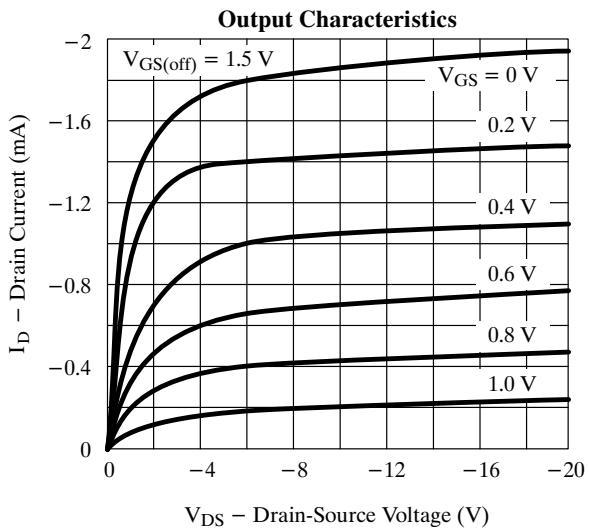
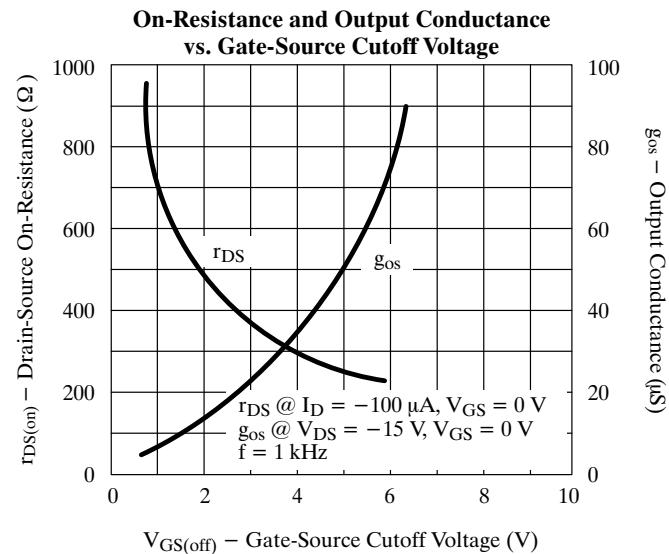
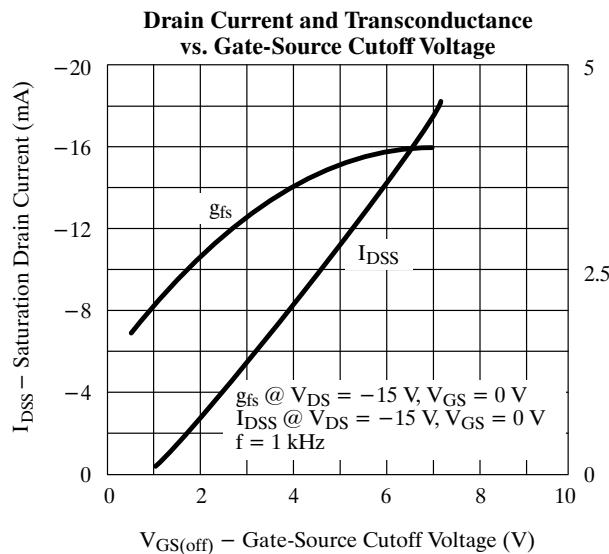
Parameter	Symbol	Test Conditions	Typ ^b	Limits						Unit	
				2N5460		2N5461		2N5462			
				Min	Max	Min	Max	Min	Max		
Static											
Gate-Source Breakdown Voltage	V _{(BR)GSS}	I _G = 10 µA, V _{DS} = 0 V	55	40		40		40			V
Gate-Source Cutoff Voltage	V _{GS(off)}	V _{DS} = -15 V, I _D = -1 µA		0.75	6	1	7.5	1.8	9		
Saturation Drain Current ^c	I _{DSS}	V _{DS} = -15 V, V _{GS} = 0 V		-1	-5	-2	-9	-4	-16	mA	
Gate Reverse Current	I _{GSS}	V _{GS} = 20 V, V _{DS} = 0 V T _A = 100°C	0.003 0.0003		5		5		5	nA	
Gate Operating Current	I _G	V _{DG} = -20 V, I _D = -0.1 mA	3								pA
Drain Cutoff Current	I _{D(off)}	V _{DS} = -15 V, V _{GS} = 10 V	-5								
Gate-Source Voltage	V _{GS}	V _{DS} = -15 V	I _D = -0.1 mA I _D = -0.2 mA I _D = -0.4 mA	1.3 2.3 3.8	0.5 4 0.8 4.5 1.5 6						V
Gate-Source Forward Voltage	V _{GS(F)}	I _G = -1 mA, V _{DS} = 0 V	-0.7								
Dynamic											
Common-Source Forward Transconductance	g _{fs}	V _{DS} = -15 V, V _{GS} = 0 V f = 1 kHz			1	4	1.5	5	2	6	mS
Common-Source Output Conductance	g _{os}					75		75		75	µS
Common-Source Input Capacitance	C _{iss}	V _{DS} = -15 V, V _{GS} = 0 V f = 1 MHz		4.5		7		7		7	pF
Common-Source Reverse Transfer Capacitance	C _{rss}			1.2							
Common-Source Output Capacitance	C _{oss}			1.5		2		2		2	
Equivalent Input Noise Voltage	̄e _n	V _{DS} = -15 V, V _{GS} = 0 V f = 100 Hz	15		115		115		115		nV/√Hz
Noise Figure	NF	V _{DS} = -15 V, V _{GS} = 0 V f = 100 Hz, R _G = 1 MΩ, BW = 1 Hz	0.2		2.5		2.5		2.5		dB

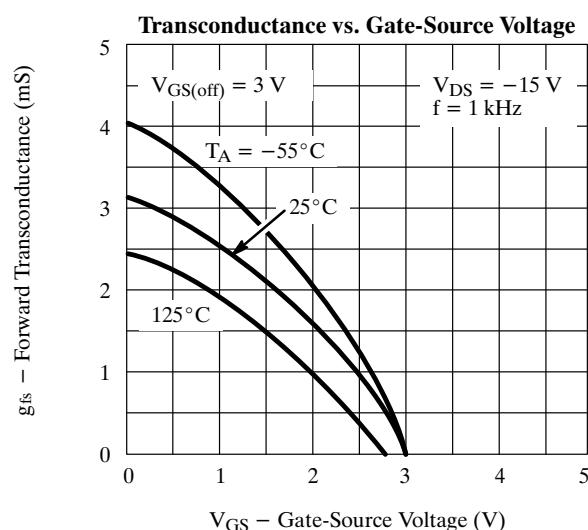
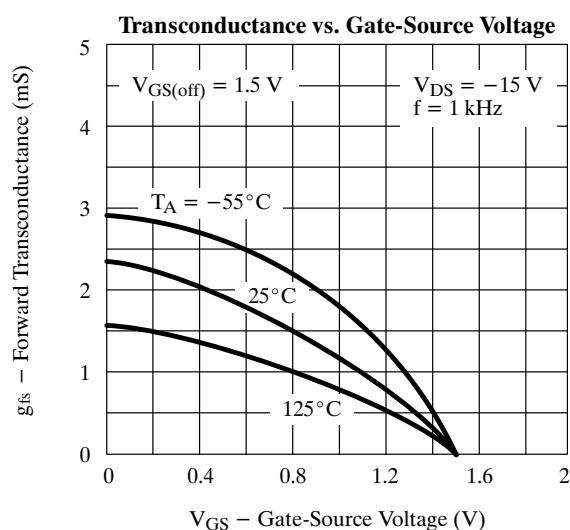
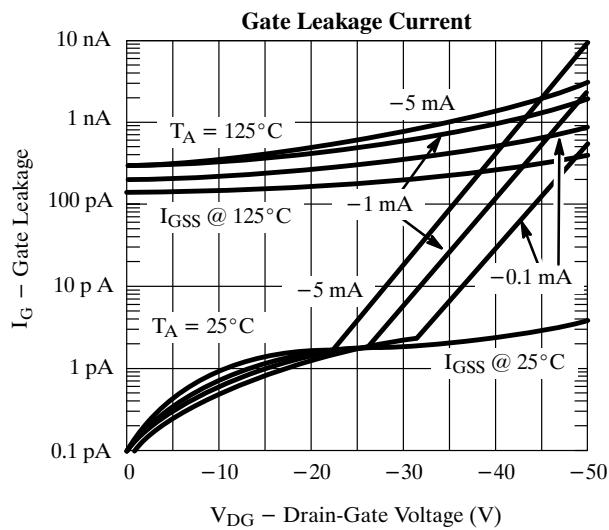
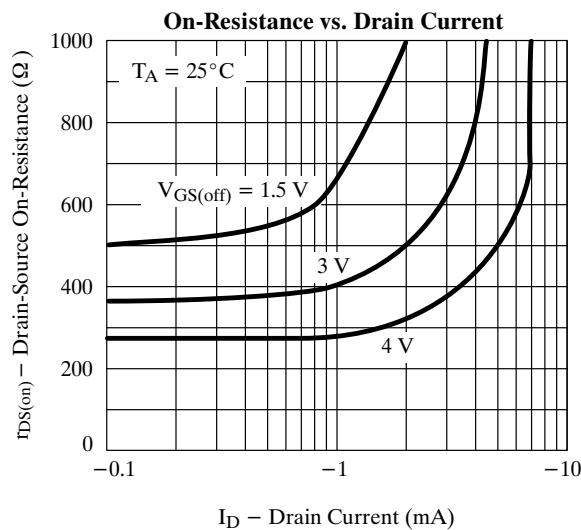
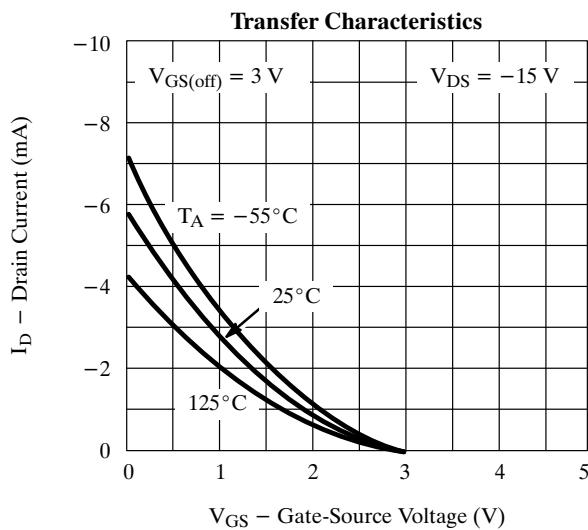
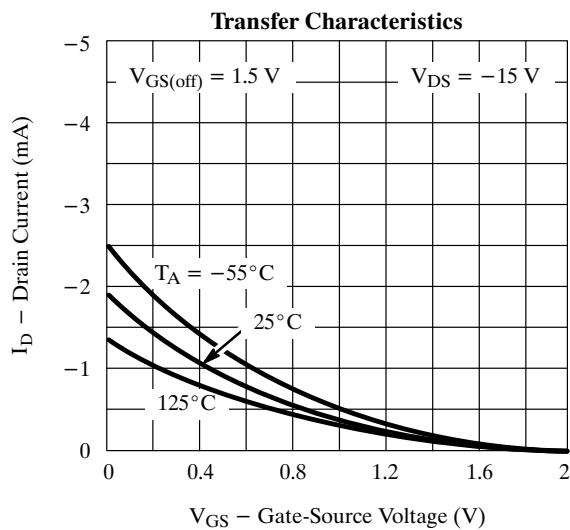
Notes

- a. T_A = 25°C unless otherwise noted.
- b. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- c. Pulse test: PW ≤ 300 µs duty cycle ≤ 2%.

PSCIB

Typical Characteristics



2N5460/5461/5462**Typical Characteristics (Cont'd)**

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Typical Characteristics (Cont'd)

